



## SUPPLEMENTAL APPLICATION DATA SHEET

## APPLICATION INFORMATION

Application Number:: 10/554,620  
Application Date:: 10/27/05  
Application Type:: REGULAR  
Subject Matter:: UTILITY  
CD-ROM or CD-R?:: NONE  
Title:: DYNAMIC MATRIX SENSITIVITY  
MEASURING INSTRUMENT FOR  
INERTIAL SENSORS, AND  
MEASURING METHOD THEREFOR  
Attorney Docket Number:: 280512US2PCT  
Total Drawing Sheets:: 9

## INVENTOR INFORMATION

Applicant Authority Type:: INVENTOR  
Primary Citizenship Country:: Japan  
Status:: FULL CAPACITY  
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## CORRESPONDENCE INFORMATION

Correspondence Customer Number:: 22850

## REPRESENTATIVE INFORMATION

Representative Customer Number:: 22850

## DOMESTIC PRIORITY INFORMATION

Application::	Continuity Type::	Parent Application::	Parent Filing Date::
This Application	National Stage of	PCT/JP04/06148	04/28/04

## FOREIGN PRIORITY INFORMATION

Application Number:	Country::	Filing Date::	Priority Claimed::
2003-123417	Japan	04/28/03	YES
2003-360287	Japan	10/21/03	YES

#### ASSIGNMENT INFORMATION

Assignee Name:: National Inst. of Adv. Industrial Science & Tech.  
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